Welcome to the World of Standards



World Class Standards

THE ETSI TEST DESCRIPTION LANGUAGE (TDL)

Results from the ETSI project STF 454

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Motivation and introduction

Oesign principles

An example

Conclusions, next steps



MOTIVATION AND INTRODUCTION

Validating Complex Systems

Engineered systems become more and more complex

- Complex design (\rightarrow system of systems)
- Complex behavior (\rightarrow real-time)
- Complex data (→big data)
- Validation and testing need to cope with complexity
 - Proper modeling techniques
 - Proper test automation
 - Proper fault analysis techniques



Intelligent Transport Systems © ETSI

Software Development Turns Agile

An agile process follows different approaches

- Story/feature driven modeling
- Test driven development, etc.
- Leads to scenario-based approach in testing
 - Describe a scenario of interacting with the system
 - Define test objectives from requirements and connect them to scenarios
 - Derive tests from scenarios and automate them



TDL Addresses Needs from Practice

ETS

TDL for testing reactive distributed real-time systems

- Provides common black-box testing concepts
- Adjustable to domain-specific needs
- Supporting agile testing process

TDL is standardized

- Clear semantics
- Interoperability of tools and test specifications
- Maintained and kept updated with user needs

TDL use cases

- Manual specification of tests for functional/conformance/interoperability testing
- Representing tests from other sources, e.g. output from MBT test generators
- Documentation of tests



DESIGN PRINCIPLES



TDL is Adjustable by User

Concrete syntax may cover only parts of the meta-model

ETS

- Meta-model can be extended by a user if need arises
- User extensions of the meta-model can be subjected to further TDL standardization and maintenance



Key elements of a TDL specification

Test configuration

• Set of interacting components in the roles Tester or SUT

ETS

Test description

- Represents the expected foreseeable (passing) behaviour,
 i.e. any deviation is a fail
- Expresses a test in terms of interactions of data exchanged between tester and SUT components
- Interactions are **totally ordered**, i.e. they are implicitly synchronized among components
- Test data
 - Represented as abstract name tuples

TDL Meta-Model Overview



ETS



AN EXAMPLE

Example: Scenario on a Rail Interlocking System (Siemens, MBAT)

testDescription: StopAndProceed

«testObjective» reference RQ-1.2.3 description "Verify that the train stops at a signal showing 'stop' and proceeds after signal aspect changes to 'proceed'." «SUT» «Tester» **TrainSystem** Operator : CompType : CompType <u>gate1</u> gate1 step RequestTrainPower(1.0) RequestSwitchPosition(85, Reverse) ATPStatus(516, 0) [interrupt] ATPStatus(Not 516) step RequestSignalAspect(516, Proceed) ATPStatus(912) [interrupt] ATPSatus(Not 912)

ETS

Test Configuration



Test Description

Generated Editor for Textual TDL Specifications (EMFText)





CONCLUSIONS, NEXT STEPS

Conclusions, Next Steps

ETSI

- TDL meta-model is available currently as an ETSI draft standard
 - Further validation of the meta-model necessary
 - Final draft for publication planned for January 2014
- Next steps
 - Design of concrete syntaxes (graphical + exchange format)
 - Getting tool support: editors, analyzers, test generators
 - Further refinement of the TDL meta-model
 - Extend TDL to support test automation
 - Extensions to ensure executability
 - Composition of test descriptions \rightarrow User story models

Team & Acknowledgement

Team

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